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Attorney's Docket No.: 10417-084001 / F51-134741M/SW

2815
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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant : Izuo Iida
Serial No. : 09/876,554
Filed : June 7, 2001
Title : METHOD OF MANUFACTURING SEMICONDUCTOR DEVICE

Art Unit : 2815
Examiner : N. Drew Richards

MAIL STOP AMENDMENT

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

INFORMATION DISCLOSURE STATEMENT

Copies of the references listed on the attached form PTO-1449 are enclosed. A copy of a communication from a foreign patent office in a counterpart application is also enclosed.

An English-language abstract is enclosed for listed reference AL.

This statement is being filed after a first Office action on the merits, but before receipt of a final Office action or a Notice of Allowance. I, the undersigned, hereby certify that each item of information contained in this statement was cited in a communication from a foreign patent office in a counterpart foreign application, the communication being dated October 11, 2004, which is not more than three months prior to the filing of this statement. Please apply any charges or credits to Deposit Account No. 06-1050.

Respectfully submitted,

Date: 11/1/04

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Substitute Form PTO-1449 (Modified) Information Disclosure Statement by Applicant (Use several sheets if necessary) (37 CFR §1.98(b))	U.S. Department of Commerce Patent and Trademark Office	Attorney's Docket No. 10417-084001	Application No. 09/876,554
	Applicant Izuo Iida		
	Filing Date June 7, 2001	Group Art Unit 2815	

U.S. Patent Documents

Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
	AA	5,879,993	03/09/1999	Chien et al.			
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						

Foreign Patent Documents or Published Foreign Patent Applications

Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Subclass	Translation	
							Yes	No
	AL	11-68070	3/9/1999	Japan				
	AM	EP 0454051A	10/30/1991	EPO				
	AN	EP 0305741A2	03/08/1989	EPO				
	AO							
	AP							

Other Documents (include Author, Title, Date, and Place of Publication)

Examiner Initial	Desig. ID	Document
	AQ	
	AR	
	AS	
	AT	

Examiner Signature	Date Considered
EXAMINER: Initials citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.	